

<b>Notice of References Cited</b>	Application/Control No. 09/683,677	Applicant(s)/Patent Under Reexamination DEVINS ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	"An Embedded PowerPC SOC for Test and Measurement Applications", 2000 IEEE, Blaner et al.
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